Se	arch l	Votes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,894	HAN ET AL.	
Examiner	Art Unit	
Hai C. Pham	2861	

	SEARCHED		
Class	Subclass	Date	Examiner
347	231, 243, 259-261	6/27/2006	НР
318	141, 779	6/27/2006	HP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
]		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search	6/27/2006	HP